

| | | | | |
|-----------------------------------|---------------------------------------|--|--|-------------|
| Notice of References Cited | Application/Control No. 10/736,647 | | Applicant(s)/Patent Under Reexamination SHIN, AKIHIRO | |
| | Examiner JASON K. LIN | | Art Unit 2623 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-------------------|----------------|
| * | A | US-2003/0009542 | 01-2003 | Kasal et al. | 709/222 |
| * | B | US-6,975,581 | 12-2005 | Medina et al. | 370/401 |
| * | C | US-7,336,680 | 02-2008 | Sorenson et al. | 370/468 |
| * | D | US-5,892,912 | 04-1999 | Suzuki et al. | 370/395.53 |
| * | E | US-6,405,371 | 06-2002 | Oosterhout et al. | 725/39 |
| * | F | US-4,868,681 | 09-1989 | Opelt, Christian | 386/95 |
| * | G | US-5,978,651 | 11-1999 | Eto et al. | 348/14.13 |
| * | H | US-6,873,624 | 03-2005 | Johansson et al. | 370/465 |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|-----------------|----------------|----------------|
| * | N | WO 9844684 A1 | 10-1998 | World Intellect | EKSTROM et al. | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.